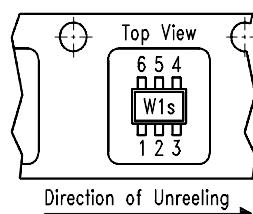
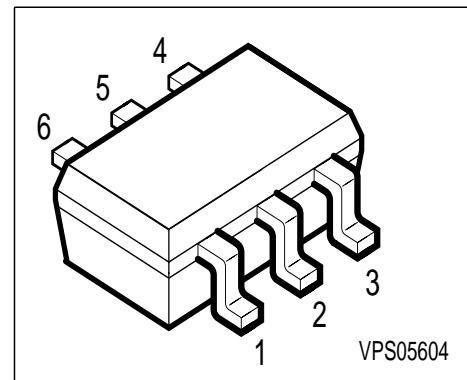


NPN Silicon Switching Transistor Array

Preliminary data

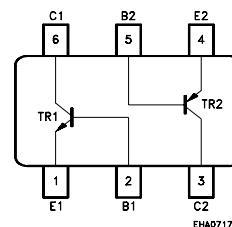
- High current gain
- Low collector-emitter saturation voltage
- Two (galvanic) internal isolated NPN/PNP Transistors in one package



Marking on SOT-363 package
(for example W1s)
corresponds to pin 1 of device

Position in tape: pin 1
opposite of feed hole side

EHA07193



EHA07177

PIN Configuration

Type	Marking	Ordering Code	Package	NPN-Transistor	1 = E	2 = B	6 = C
SMBT 3904PN	s3P	Q62702-C	SOT-363	PNP-Transistor	4 = E	5 = B	6 = C

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CEO}	40	V
Collector-base voltage	V_{CBO}	40	
Emitter-base voltage	V_{EBO}	6	
DC collector current	I_C	200	mA
Total power dissipation, $T_S = 115^\circ\text{C}$	P_{tot}	250	mW
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	- 65...+150	

Thermal Resistance

Junction ambient 1)	R_{thJA}	≤ 275	K/W
Thermal resistance, chip case	R_{thJC}	≤ 140	

1) Package mounted on pcb 40mm x 40mm x 1.5mm / 0.5cm

Electrical Characteristics at $T_A=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics per Transistor					
Collector-emitter breakdown voltage $I_C = 1 \text{ mA}, I_B = 0$	$V_{(\text{BR})\text{CEO}}$	40	-	-	V
Collector-base breakdown voltage $I_C = 10 \mu\text{A}, I_B = 0$	$V_{(\text{BR})\text{CBO}}$	40	-	-	
Emitter-base breakdown voltage $I_E = 10 \mu\text{A}, I_C = 0$	$V_{(\text{BR})\text{EBO}}$	6	-	-	
Collector cutoff current $V_{CB} = 30 \text{ V}, I_E = 0$	I_{CBO}	-	-	50	nA
DC current gain 1) $I_C = 100 \mu\text{A}, V_{CE} = 1 \text{ V}$ $I_C = 1 \text{ mA}, V_{CE} = 1 \text{ V}$ $I_C = 10 \text{ mA}, V_{CE} = 1 \text{ V}$ $I_C = 50 \text{ mA}, V_{CE} = 1 \text{ V}$ $I_C = 100 \text{ mA}, V_{CE} = 1 \text{ V}$	h_{FE}	40 70 100 60 30	- - - - -	- - 300 - -	-
Collector-emitter saturation voltage1) $I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$ $I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$	V_{CEsat}	- -	- -	0.25 0.4	V
Base-emitter saturation voltage 1) $I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$ $I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$	V_{BEsat}	0.65 -	- -	0.85 0.95	

1) Pulse test: $t < 300\mu\text{s}$; D < 2%

Electrical Characteristics at $T_A=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics per Transistor					
Transition frequency $I_C = 10 \text{ mA}, V_{CE} = 5 \text{ V}, f = 100 \text{ MHz}$	f_T	250	-	-	MHz
Collector-base capacitance $V_{CB} = 10 \text{ V}, f = 1 \text{ MHz}$	C_{cb}	-	-	4.5	pF
Emitter-base capacitance $V_{EB} = 0.5 \text{ V}, f = 1 \text{ MHz}$	C_{eb}	-	-	10	
Short-circuit input impedance $I_C = 2 \text{ mA}, V_{CE} = 5 \text{ V}, f = 1 \text{ kHz}$	h_{11e}	2	-	12	k Ω
Open-circuit reverse voltage transfer ratio $I_C = 2 \text{ mA}, V_{CE} = 5 \text{ V}, f = 1 \text{ kHz}$	h_{12e}	0.1	-	10	10^{-4}
Short-circuit forward current transfer ratio $I_C = 2 \text{ mA}, V_{CE} = 5 \text{ V}, f = 1 \text{ kHz}$	h_{21e}	100	-	400	-
Open-circuit output admittance $I_C = 2 \text{ mA}, V_{CE} = 5 \text{ V}, f = 1 \text{ kHz}$	h_{22e}	1	-	60	μs
Noise figure $I_C = 100 \mu\text{A}, V_{CE} = 5 \text{ V}, R_S = 1 \text{ k}\Omega,$ $f = 1 \text{ kHz}, \Delta f = 200 \text{ Hz}$	F	-	-	5	dB
Delay time $V_{CC} = 3 \text{ V}, I_C = 10 \text{ mA}, I_{B1} = 1 \text{ mA},$ $V_{BE(\text{off})} = 0.5 \text{ V}$	t_d	-	-	35	ns
Rise time $V_{CC} = 3 \text{ V}, I_C = 10 \text{ mA}, I_{B1} = 1 \text{ mA},$ $V_{BE(\text{off})} = 0.5 \text{ V}$	t_r	-	-	35	
Storage time $V_{CC} = 3 \text{ V}, I_C = 10 \text{ mA}, I_{B1}=I_{B2} = 1\text{mA}$	t_{stg}	-	-	225	
Fall time $V_{CC} = 3 \text{ V}, I_C = 10 \text{ mA}, I_{B1}=I_{B2} = 1\text{mA}$	t_f	-	-	75	